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AMENDMENTS TO THE SPECIFICATION

PATENT

Please replace paragraph [0032] with the following amended paragraph:

[0032] The above-discussed and other results are analyzed at block 440 and characteristics of the circuit design are identified therefrom. If information about the circuit design sufficient for generating a BSDL file is not available at block 450, a new device-specific test bench is built at block 452. The process of analysis and identification of circuit characteristics then resumes at block 440 with the new devicespecific test bench, with new test vectors being applied to the circuit design. If sufficient information for generating the BSDL file is available at block 450, a pin-topackage pinout file for the circuit design is parsed at block 460 and a BSDL file is generated using the analyzed results at block 470.